Notice of References Cited Application/Control No. 09/903,211 Examiner A. Sefer Applicant(s)/Patent Under Reexamination HIRATSUKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0035923	11-2001	Cha et al.	349/65
	В	US-4,974,257	11-1990	Ibanez et al.	379/143
	С	US-2002/0186333	12-2002	Ha et al.	349/58
	D	US-5,835,139	11-1998	Yun et al.	349/58
	Е	US-4,771,277	09-1988	Barbee et al.	345/173
	F	US-5,335,076	08-1994	Reh et al.	348/794
	G	US-5,422,751	06-1995	Lewis et al.	349/59
	Н	US-4,326,193	04-1982	Markley et al.	345/168
	l	US-5,894,192	04-1999	Grabis, Dietrich W.	313/478
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 527264	02-1993	Germany	Grabis	
	0					
	P					
	·Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.